## Applicant(s)/Patent Under Application/Control No. Reexamination 09/600,180 MEIER ET AL. Notice of References Cited Art Unit Examiner Page 1 of 1 David M. Naff 1651 **U.S. PATENT DOCUMENTS** Document Number Date Name Classification Country Code-Number-Kind Code MM-YYYY 01-1978 Α US-4,070,348 Draemer et al 260/79.3 В US-4,247,643 01-1981 Kramer et al 435/178 435/231 С US-5,326,698 07-1994 Kasche et al D US-5,342,646 08-1994 Kleese et al 427/2.1 Ε US-F US-US-G US-Н ١ US-J US-US-Κ L US-US-М FOREIGN PATENT DOCUMENTS Document Number Date Country Name Classification Country Code-Number-Kind Code MM-YYYY Ν 0 Р Q R S Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U W

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